



# **STAT 571A — Advanced Statistical Regression Analysis**

## **Chapter 4 NOTES Simultaneous Inferences and Other Topics**

© 201+ University of Arizona Statistics GIDP. All rights reserved, except where previous rights exist. No part of this material may be reproduced, stored in a retrieval system, or transmitted in any form or by any means — electronic, online, mechanical, photoreproduction, recording, or scanning — without the prior written consent of the course instructor.

# Simultaneous Inferences

- (Almost) all of the inferences we've discussed have been **Pointwise**: they apply to one and only one outcome:
  - one conf. interval on one parameter, or
  - one hypoth. test on one parameter
- To make multiple, simultaneous inferences (hypoth. tests or conf. intervals) on  $g > 1$  parameters or mean responses, we adjust the tests or conf. regions for the multiplicity.

## Multiplicity & FWER

- Why adjust? If we do not correct for the multiple inferences, error rates will be too high ( $\Leftrightarrow$  conf. levels will be too low).
- When  $g > 1$  inferences are applied to the same set of data, the **Familywise (false positive) Error Rate**, or FWER, is  
$$P[\text{any false positive error(s) among the } g \text{ inferences}]$$
- Goal: keep the FWER  $\leq \alpha$ .

# Bonferroni's Inequality

- Our mainstay adjustment is the (conservative) Bonferroni correction, based on **Bonferroni's Inequality**:
- As in Equation (4.2), for any events  $A_k$ ,

$$P[\bar{A}_1 \cap \bar{A}_2 \cap \dots \cap \bar{A}_g] \geq 1 - \sum_{k=1}^g P[A_k]$$

- This can be manipulated to place upper bounds on the FWER, or lower bounds on the FW conf. level.

## Bonferroni's Inequality (cont'd)

- For instance, suppose  $A_1$  is 'noncoverage' of a parameter  $\beta_0$  and  $A_2$  is 'noncoverage' of another parameter  $\beta_1$ .
- Then, the complementary events,  $\bar{A}_k$ , are correct 'coverage.' Bonferroni tells us that  
$$P[\text{jointly covering both}] \geq 1 - P[\text{noncover } \beta_0] - P[\text{noncover } \beta_1]$$
- Say  $P[\text{noncover } \beta_j] = \alpha$ . Then  
$$P[\text{jointly covering both}] \geq 1 - \alpha - \alpha = 1 - 2\alpha.$$
- (So, divide each orig.  $\alpha$  by 2 to get  $\geq 1 - \alpha$ .)

# Bonferroni Adjustment

Suppose we study the SLR model with  $Y_i = \beta_0 + \beta_1 X_i + \varepsilon_i$ . A pointwise conf. int. on either  $\beta_j$  is

$$b_j \pm t\left(1 - \frac{\alpha}{2}; n-2\right)s\{b_j\}$$

But from Bonferroni, a FW conf. statement on both ( $g = 2$ )  $\beta_j$  parameters is

$$b_j \pm t\left(1 - \frac{(\alpha/2)}{2}; n-2\right)s\{b_j\}$$

for  $j = 0, 1$ .

## Bonferroni Adjustment (cont'd)

- Notice what this does: in effect, it simply **changes the  $\alpha$ -value in any critical point to  $\alpha/g$ .**

- Above,  $g = 2$ , so use  $b_j \pm B s\{b_j\}$ , where

$$B = t\left(1 - \frac{\alpha}{4}; n-2\right)$$

or, more generally

$$B = t\left(1 - \frac{(\alpha/g)}{2}; n-2\right)$$

is the **Bonferroni-adjusted critical point**

## **Bonferroni Conf. Intervals on $E\{Y_h\}$**

**An important example is with multiple conf. intervals for the mean response,  $E\{Y_h\}$ , at any set of  $g > 1$  predictor values  $X_h$  ( $h = 1, \dots, g$ ).**

**Here, the family of (conservative) simultaneous conf. intervals becomes**

$$\hat{Y}_h \pm B s\{\hat{Y}_h\}$$

**( $h = 1, \dots, g$ ) for  $B = t(1 - \frac{1}{2}\{\alpha/g\}; n-2)$ .**



## Working-Hotelling-Scheffé (WHS) Intervals on $E\{Y_h\}$

- We can alternatively apply the WHS conf. band to build multiple conf. intervals for the mean response,  $E\{Y_h\}$ , at any set of  $g > 1$  predictor values  $X_h$  ( $h = 1, \dots, g$ ).
- The family of (conservative) simultaneous conf. intervals is

$$\hat{Y}_h \pm W s\{\hat{Y}_h\}$$

where the **WHS-adjusted critical point** is based on  $W^2 = 2F(1 - \alpha; 2, n-2)$ .

## WHS or Bonferroni?

- For any set of  $g > 1$  predictor values  $X_h$  ( $h = 1, \dots, g$ ), both the B and W crit. points are valid, if conservative.
- So, **use the WHS value if  $W \leq B$** , and use Bonferroni if  $B < W$ .
- Notice: The WHS is exact for *all* X-values. So, it can be used for **post hoc intervals** on  $E\{Y_h\}$  at any finite collection of  $X_h$ 's. (It is the only valid conf. int. for post hoc “data snooping.”)

## Toluca Example (cont'd)

- In the Toluca Data example (CH01TA01), suppose we want  $g = 3$  (three) 90% conf. int's at  $X_h = 30, 65, 100$ . Here,  $df_E = 25 - 2 = 23$ .
- The Bonfer. point is  $t(1 - \frac{1}{2}\{0.10/3\}; 23)$ :  
> qt( 1-(.10/6), 23 )  
2.263728
- The WHS point is  $\{2F(1 - 0.10; 2, 23)\}^{1/2}$ :  
> sqrt( 2\*qf(.90, 2, 23) )  
2.258003
- Since  $W \leq B$ , use the WHS adjusted crit. point.

## §4.4: Regression Thru the Origin

- If  $\beta_0 = 0$ , the SLR model simplifies to  $E\{Y_i\} = \beta_1 X_i$  ( $i = 1, \dots, n$ ).
- The LS estimate of  $\beta_1$  is  $b_1 = \sum Y_i X_i / \sum X_i^2$
- The corresp. std. error is

$$s\{b_1\} = \sqrt{\text{MSE} / \sum X_i^2}$$

where the MSE now has **n-1** df.

- A  $1 - \alpha$  conf. interval for  $\beta_1$  is  
$$b_1 \pm t(1 - \alpha/2; n-1)s\{b_1\}$$

## Regression Thru the Origin (cont'd)

For inferences on  $E\{Y_h\}$ , use:

- LS estimator:  $\hat{Y}_h = b_1 X_h$

- std. error:  $s\{\hat{Y}_h\} = |X_h| \sqrt{\frac{\text{MSE}}{\sum X_i^2}}$

- (pointwise) conf. int.:

$$\hat{Y}_h \pm t\left(1 - \frac{\alpha}{2}; n-1\right) s\{\hat{Y}_h\}$$

## Regression Thru the Origin (cont'd)

For prediction of a future  $Y_{h(\text{new})}$  at  $X_{h(\text{new})}$ , use:

- LS estimator:  $\hat{Y}_{h(\text{new})} = b_1 X_{h(\text{new})}$

- prediction error:

$$s\{\text{pred}\} = \sqrt{\text{MSE} \left( 1 + \frac{X_{h(\text{new})}^2}{\sum X_i^2} \right)}$$

- (pointwise) prediction int.:

$$\hat{Y}_{h(\text{new})} \pm t\left(1 - \frac{\alpha}{2}; n-1\right) s\{\text{pred}\}$$

## Warehouse Data (CH04TA02)

- $X$  = work units,  $Y$  = variable labor costs.
- Expect  $E\{Y\} = 0$  when  $X = 0$ , so fix  $\beta_0 = 0$ :

```
> CH04TA02.lm = lm(Y ~ X -1 )
```

```
> summary( CH04TA02.lm )
```

Call:

```
lm(formula = Y ~ X - 1)
```

Coefficients:

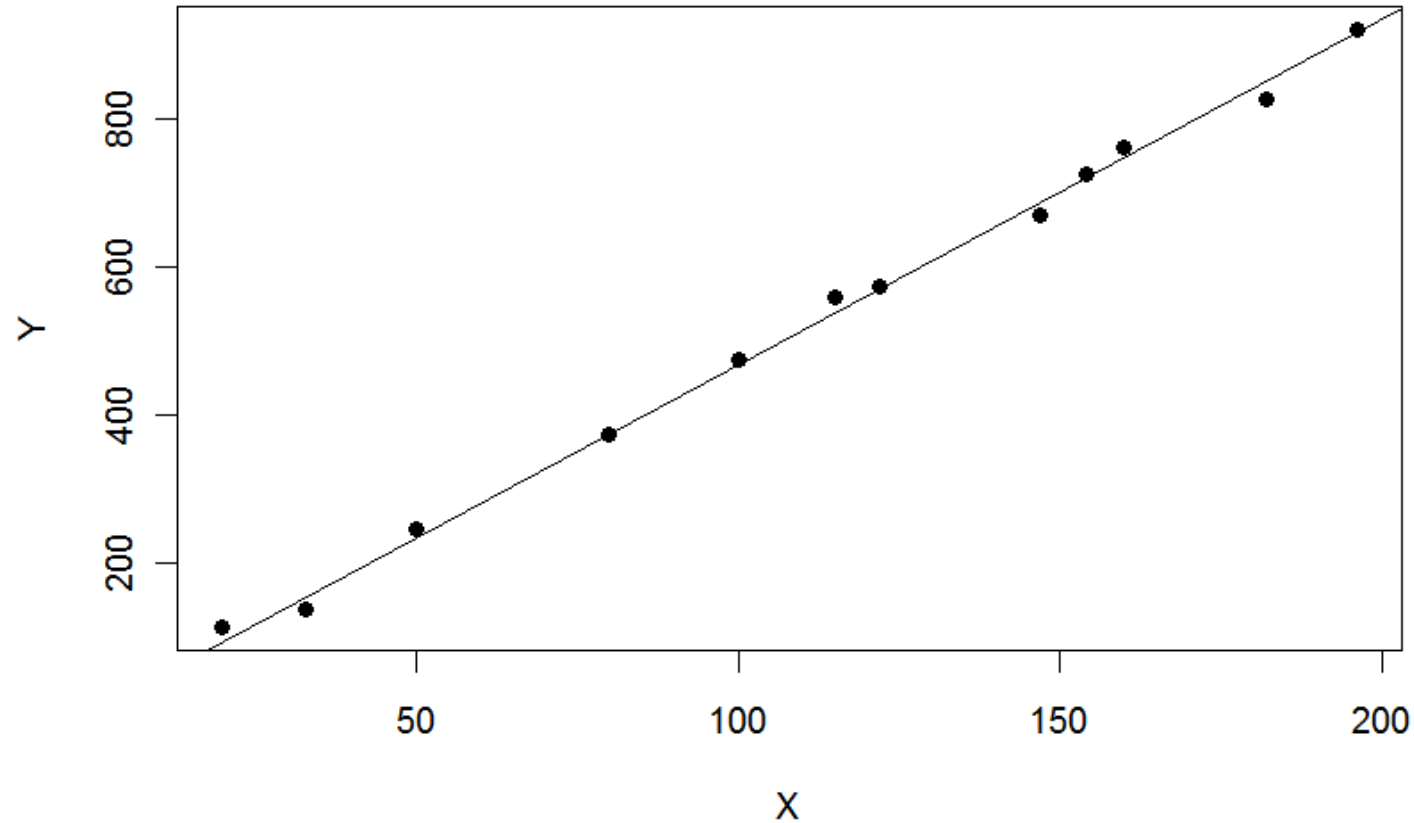
	Estimate	Std. Error	t value	Pr(> t )
X	4.68527	0.03421	137	<2e-16

```
> confint(CH04TA02.lm)
```

	2.5 %	97.5 %
X	4.609989	4.760559

# Warehouse Data (CH04TA02) (cont'd)

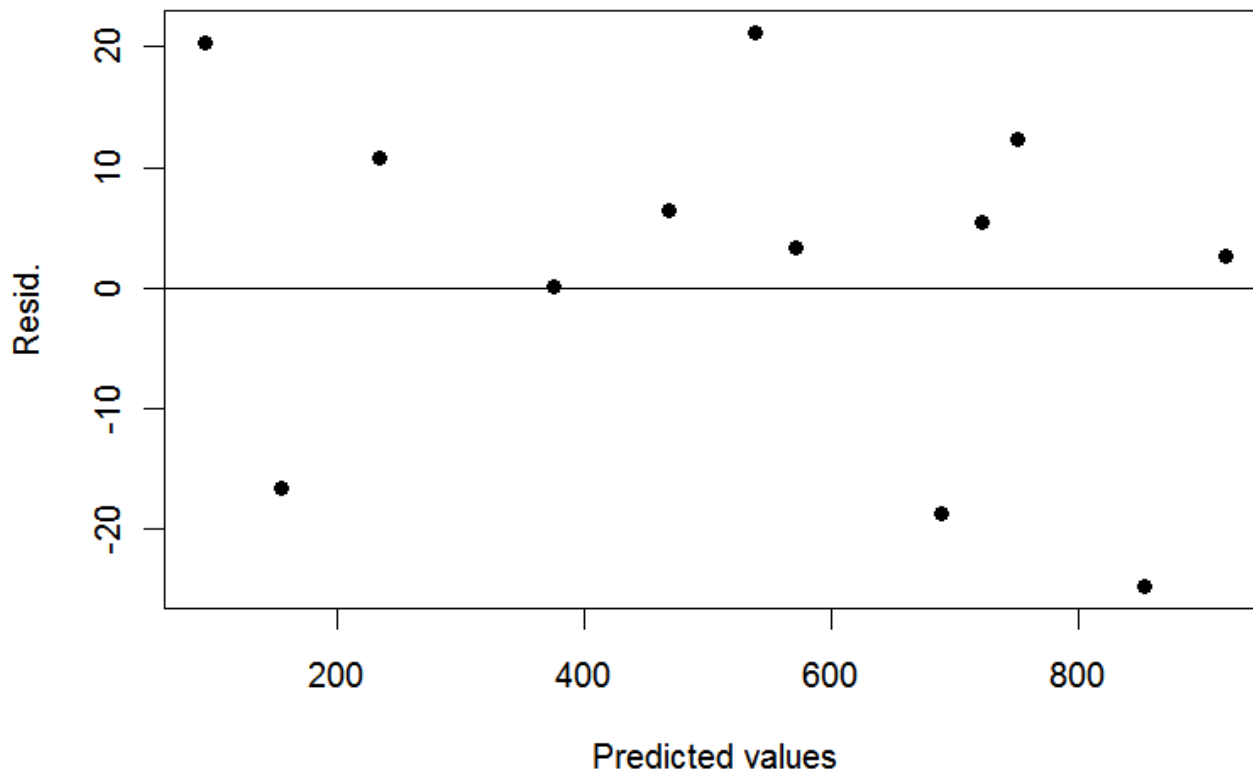
```
> plot( Y~X, pch=19 )  
> abline( lm(Y ~ X-1) )
```





# Warehouse Data (CH04TA02) (cont'd)

```
> plot( resid(lm(Y ~ X-1)) ~  
        predict(lm(Y ~ X-1)) )  
> abline( h=0 )
```



## §4.6: Inverse Prediction

- We can reverse the prediction effort and ask, **what value of  $X$  produces a given  $Y$ ?** This is an **inverse prediction** problem.
  - also called: “inverse regression” or “calibration”
- Assume the SLR model:  $Y_i = \beta_0 + \beta_1 X_i + \varepsilon_i$ , with  $\varepsilon_i \sim \text{i.i.d. } N(0, \sigma^2)$ .
- Given  $Y_{h(\text{new})}$ , we want to find the  $X_{h(\text{new})}$  that yields this  $Y_{h(\text{new})}$ .

## Inverse Prediction (cont'd)

Clearly, if  $\hat{Y}_h = b_0 + b_1 X_h$ , we can invert this into  $\hat{X}_{h(\text{new})} = \frac{Y_{h(\text{new})} - b_0}{b_1}$  for  $b_1 \neq 0$ .

The prediction error can be found as

$$s\{\hat{X}_{h(\text{new})}\} = \sqrt{\frac{\text{MSE}}{b_1^2} \left( 1 + \frac{1}{n} + \frac{(\hat{X}_{h(\text{new})} - \bar{X})^2}{\sum (X_i - \bar{X})^2} \right)}$$

from which a  $1-\alpha$  prediction int. is simply

$$\hat{X}_{h(\text{new})} \pm t\left(1 - \frac{\alpha}{2}; n-2\right) s\{\hat{X}_{h(\text{new})}\}$$

## §4.7: Optimal Design

- Notice that terms containing the  $X_i$ 's, such as  $\bar{X}$  and  $\sum(X_i - \bar{X})^2$ , appear throughout these various expressions. If the  $X_i$ 's are under control of the investigator, we can manipulate these quantities.
- **Why?** We might be able to make a std. error smaller and hence tighten a conf. int. or increase power in an hypoth. test.

## Optimal Design (cont'd)

Consider the **margin of error** on the conf. int. for  $\beta_1$ :

$$\begin{aligned} \text{MOE} &= \pm t\left(1 - \frac{\alpha}{2}; n-2\right) s\{b_1\} \\ &= \pm t\left(1 - \frac{\alpha}{2}; n-2\right) \sqrt{\frac{\text{MSE}}{\sum_{i=1}^n (X_i - \bar{X})^2}} \end{aligned}$$

Clearly, as  $\sum_{i=1}^n (X_i - \bar{X})^2 \uparrow$  the MOE  $\downarrow$  and the conf. int. will get tighter.

## **Optimal Design (cont'd)**

- **So, wherever possible, always try to select the spacing and number (including replicates) of the  $X_i$ 's to optimize the conf. int's and hypoth. tests.**
- **See the exposition on pp. 170-172.**